

**Notice of References Cited**

Application/Control No.

09/311,753

Applicant(s)/Patent Under  
Reexamination  
INOUE ET AL.

Examiner

Kevin M Bernatz

Art Unit

1773

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**U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-6,129,964	10-2000	Seth, Jayshree	24/306
B	US-			
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E	US-			
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J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

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N	JP 08-020751-A	01-1996	Japan	Miyahara et al.	
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**NON-PATENT DOCUMENTS**

Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

U	JPO Abstract Translation of JP 08-020751-A (Clipped Image No. JP408020751A)
V	Machine Translation of JP 08-020751-A
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y of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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